

Product Specification

XBLW SN74LVC1G00

Single 2-input NAND Gate

WEB | www.xinboleic.com



Description

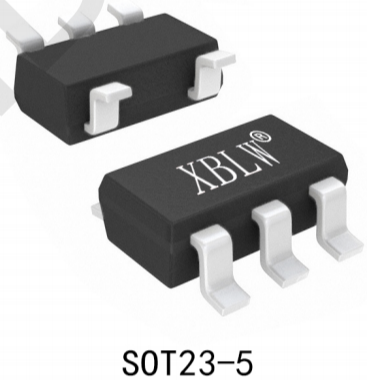
The SN74LVC1G00 is a single 2-input NAND Gate. Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of these devices as translators in mixed 3.3 V and 5 V environments. Schmitt-trigger action at all inputs makes the circuit tolerant of slower input rise and fall times.

Features

- Wide supply voltage range from 1.65V to 5.5V
- $\pm 24\text{mA}$ output drive ($V_{CC}=3.0\text{V}$)
- CMOS low power consumption
- Input accepts voltages up to 5V
- Specified from -40°C to $+125^{\circ}\text{C}$
- Packaging information: SOT-23-5/SOT-353

Applications

- AV Receiver
- Embedded PC
- Tablet: Enterprise
- Audio Dock: Portable
- Blu-ray Player and Home Theater
- Video Analytics: Server
- Wireless Headset, Keyboard, and Mouse
- Personal Digital Assistant (PDA)
- MP3 Player/Recorder (Portable Audio)
- Solid State Drive (SSD): Client and Enterprise
- TV: LCD/Digital and High-Definition (HDTV)
- Power: Telecom/Server AC/DC Supply: Single Controller: Analog and Digital



Ordering Information:

Product Model	Package Type	Marking	Packing	Packing Qty
XBLW SN74LVC1G00T235	SOT-23-5	AHXX	Tape	3000Pcs/Reel
XBLW SN74LVC1G00T353	SOT-353	AHXX	Tape	3000Pcs/Reel

Block Diagram

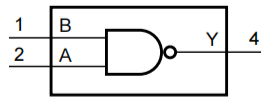


Figure 1. Logic symbol

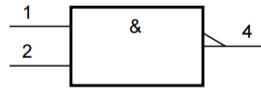


Figure 2. IEC logic symbol

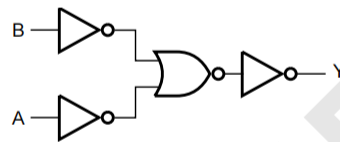
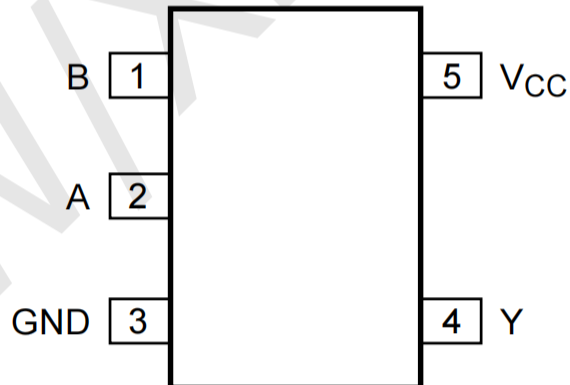


Figure 3. Logic diagram

Pin Configurations



Pin Description

Pin No.	Pin Name	Description
1	B	data input
2	A	data input
3	GND	ground (0V)
4	Y	data output
5	V _{CC}	supply voltage

Function Table

Input		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

Note: H=HIGH voltage level; L=LOW voltage level.

Electrical Parameter

Absolute Maximum Ratings

(Voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Max.	Unit
supply voltage	V_{CC}	-	-0.5	+6.5	V
input clamping current	I_{IK}	$V_I < 0V$	-50	-	mA
input voltage	V_I	-	-0.5	+6.5	V
output clamping current	I_{OK}	$V_O > V_{CC}$ or $V_O < 0V$	-	± 50	mA
output voltage	V_O	Active mode	-0.5	$V_{CC}+0.5$	V
		Power-down mode	-0.5	+6.5	V
output current	I_O	$V_O=0V$ to V_{CC}	-	± 50	mA
supply current	I_{CC}	-	-	100	mA
ground current	I_{GND}	-	-100	-	mA
storage temperature	T_{stg}	-	-65	+150	°C
total power dissipation	P_{tot}	-	-	250	mW
soldering temperature	T_L	10s	260		°C

Recommended Operating Conditions

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
supply voltage	V_{CC}	-	1.65	-	5.5	V
input voltage	V_I	-	0	-	5.5	V
output voltage	V_O	Active mode	0	-	V_{CC}	V
		Power-down mode; $V_{CC}=0V$	0	-	5.5	V
ambient temperature	T_{amb}	-	-40	-	+125	°C

ESD Ratings

Parameter	Defintion	Vaue	Unit
$V_{(ESD)}$	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	± 2000	V
	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	± 1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

Electrical Characteristics

DC Characteristics 1

($T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
HIGH-level input voltage	V_{IH}	$V_{CC}=1.65\text{V to }1.95\text{V}$	$0.65 \times V_{CC}$	-	-	V	
		$V_{CC}=2.3\text{V to }2.7\text{V}$	1.7	-	-	V	
		$V_{CC}=2.7\text{V to }3.6\text{V}$	2.0	-	-	V	
		$V_{CC}=4.5\text{V to }5.5\text{V}$	$0.7 \times V_{CC}$	-	-	V	
LOW-level input voltage	V_{IL}	$V_{CC}=1.65\text{V to }1.95\text{V}$	-	-	$0.35 \times V_{CC}$	V	
		$V_{CC}=2.3\text{V to }2.7\text{V}$	-	-	0.7	V	
		$V_{CC}=2.7\text{V to }3.6\text{V}$	-	-	0.8	V	
		$V_{CC}=4.5\text{V to }5.5\text{V}$	-	-	$0.3 \times V_{CC}$	V	
HIGH-level output voltage	V_{OH}	$V_I = V_{IH} \text{ or } V_{IL}$	$I_o = -100\mu\text{A}; V_{CC}=1.65\text{V to }5.5\text{V}$	$V_{CC} - 0.1$	-	-	V
			$I_o = -4\text{mA}; V_{CC}=1.65\text{V}$	1.2	-	-	V
			$I_o = -8\text{mA}; V_{CC}=2.3\text{V}$	1.9	-	-	V
			$I_o = -12\text{mA}; V_{CC}=2.7\text{V}$	2.2	-	-	V
			$I_o = -24\text{mA}; V_{CC}=3.0\text{V}$	2.3	-	-	V
			$I_o = -32\text{mA}; V_{CC}=4.5\text{V}$	3.8	-	-	V
LOW-level output voltage	V_{OL}	$V_I = V_{IH} \text{ or } V_{IL}$	$I_o = 100\mu\text{A}; V_{CC}=1.65\text{V to }5.5\text{V}$	-	-	0.1	V
			$I_o = 4\text{mA}; V_{CC}=1.65\text{V}$	-	-	0.45	V
			$I_o = 8\text{mA}; V_{CC}=2.3\text{V}$	-	-	0.3	V
			$I_o = 12\text{mA}; V_{CC}=2.7\text{V}$	-	-	0.4	V
			$I_o = 24\text{mA}; V_{CC}=3.0\text{V}$	-	-	0.55	V
			$I_o = 32\text{mA}; V_{CC}=4.5\text{V}$	-	-	0.55	V
input leakage current	I_I	$V_I = 5.5\text{V or GND}; V_{CC}=0\text{V to }5.5\text{V}$	-	-	± 1	μA	
power-off leakage current	I_{OFF}	$V_I \text{ or } V_O = 5.5\text{V}; V_{CC}=0\text{V}$	-	-	± 2	μA	
supply current	I_{CC}	$V_I = 5.5\text{V or GND}; I_o = 0\text{A}; V_{CC}=1.65\text{V to }5.5\text{V}$	-	-	4	μA	
additional supply current	ΔI_{CC}	per pin; $V_I = V_{CC} - 0.6\text{V}; I_o = 0\text{A}; V_{CC}=2.3\text{V to }5.5\text{V}$	-	-	500	μA	
input capacitance	C_I	$V_{CC}=3.3\text{V}; V_I = \text{GND to } V_{CC}$	-	5	-	pF	

Note: All typical values are measured at $V_{CC}=3.3\text{V}$ and $T_{amb}=25^{\circ}\text{C}$.

DC Characteristics 2

 ($T_{amb} = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
HIGH-level input voltage	V_{IH}	$V_{CC}=1.65\text{V}$ to 1.95V	$0.65 \times V_{CC}$	-	-	V	
		$V_{CC}=2.3\text{V}$ to 2.7V	1.7	-	-	V	
		$V_{CC}=2.7\text{V}$ to 3.6V	2.0	-	-	V	
		$V_{CC}=4.5\text{V}$ to 5.5V	$0.7 \times V_{CC}$	-	-	V	
LOW-level input voltage	V_{IL}	$V_{CC}=1.65\text{V}$ to 1.95V	-	-	$0.35 \times V_{CC}$	V	
		$V_{CC}=2.3\text{V}$ to 2.7V	-	-	0.7	V	
		$V_{CC}=2.7\text{V}$ to 3.6V	-	-	0.8	V	
		$V_{CC}=4.5\text{V}$ to 5.5V	-	-	$0.3 \times V_{CC}$	V	
HIGH-level output voltage	V_{OH}	$V_I = V_{IH}$ or V_{IL}	$I_O = -100\mu\text{A}$; $V_{CC}=1.65\text{V}$ to 5.5V	$V_{CC} - 0.1$	-	-	V
			$I_O = -4\text{mA}$; $V_{CC}=1.65\text{V}$	0.95	-	-	V
			$I_O = -8\text{mA}$; $V_{CC}=2.3\text{V}$	1.7	-	-	V
			$I_O = -12\text{mA}$; $V_{CC}=2.7\text{V}$	1.9	-	-	V
			$I_O = -24\text{mA}$; $V_{CC}=3.0\text{V}$	2.0	-	-	V
			$I_O = -32\text{mA}$; $V_{CC}=4.5\text{V}$	3.4	-	-	V
LOW-level output voltage	V_{OL}	$V_I = V_{IH}$ or V_{IL}	$I_O = 100\mu\text{A}$; $V_{CC}=1.65\text{V}$ to 5.5V	-	-	0.1	V
			$I_O = 4\text{mA}$; $V_{CC}=1.65\text{V}$	-	-	0.7	V
			$I_O = 8\text{mA}$; $V_{CC}=2.3\text{V}$	-	-	0.45	V
			$I_O = 12\text{mA}$; $V_{CC}=2.7\text{V}$	-	-	0.6	V
			$I_O = 24\text{mA}$; $V_{CC}=3.0\text{V}$	-	-	0.8	V
			$I_O = 32\text{mA}$; $V_{CC}=4.5\text{V}$	-	-	0.8	V
input leakage current	I_I	$V_I = 5.5\text{V}$ or GND; $V_{CC}=0\text{V}$ to 5.5V	-	-	± 1	μA	
power-off leakage current	I_{OFF}	V_I or $V_O = 5.5\text{V}$; $V_{CC}=0\text{V}$	-	-	± 2	μA	
supply current	I_{CC}	$V_I = 5.5\text{V}$ or GND; $I_O = 0\text{A}$; $V_{CC}=1.65\text{V}$ to 5.5V	-	-	4	μA	
additional supply current	ΔI_{CC}	per pin; $V_I = V_{CC} - 0.6\text{V}$; $I_O = 0\text{A}$; $V_{CC}=2.3\text{V}$ to 5.5V	-	-	500	μA	

AC Characteristics 1

($T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ. ^[1]	Max.	Unit	
A, B to Y propagation delay	t_{PHL}	see Figure 5	$V_{CC}=1.65\text{V}$ to 1.95V	-	12.5	18.8	ns
			$V_{CC}=2.3\text{V}$ to 2.7V	-	10.5	15.8	ns
			$V_{CC}=2.7\text{V}$	-	10	15	ns
			$V_{CC}=3.0\text{V}$ to 3.6V	-	9.5	14.3	ns
			$V_{CC}=4.5\text{V}$ to 5.5V	-	9	13.5	ns
A, B to Y propagation delay	t_{PLH}	see Figure 5	$V_{CC}=1.65\text{V}$ to 1.95V	-	14	21	ns
			$V_{CC}=2.3\text{V}$ to 2.7V	-	10	15	ns
			$V_{CC}=2.7\text{V}$	-	9.5	14.3	ns
			$V_{CC}=3.0\text{V}$ to 3.6V	-	8.5	12.8	ns
			$V_{CC}=4.5\text{V}$ to 5.5V	-	7.5	11.3	ns

Note:

[1] Typical values are measured at $T_{amb}=25^{\circ}\text{C}$ and $V_{CC}=1.8\text{V}$, 2.5V , 2.7V , 3.3V and 5.0V respectively.

[2] Typical values are measured at $V_{CC}=3.3\text{V}$ or 5V .

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum (C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

$\sum (C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.

AC Characteristics 2

($T_{amb} = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
A, B to Y propagation delay	t_{PHL}	see Figure 5	$V_{CC}=1.65\text{V}$ to 1.95V	-	-	20.8	ns
			$V_{CC}=2.3\text{V}$ to 2.7V	-	-	17.8	ns
			$V_{CC}=2.7\text{V}$	-	-	17	ns
			$V_{CC}=3.0\text{V}$ to 3.6V	-	-	16.3	ns
			$V_{CC}=4.5\text{V}$ to 5.5V	-	-	15.5	ns
A, B to Y propagation delay	t_{PLH}	see Figure 5	$V_{CC}=1.65\text{V}$ to 1.95V	-	-	23	ns
			$V_{CC}=2.3\text{V}$ to 2.7V	-	-	17	ns
			$V_{CC}=2.7\text{V}$	-	-	16.3	ns
			$V_{CC}=3.0\text{V}$ to 3.6V	-	-	14.8	ns
			$V_{CC}=4.5\text{V}$ to 5.5V	-	-	13.3	ns

Note:

[1] Typical values are measured at $T_{amb}=25^{\circ}\text{C}$ and $V_{CC}=1.8\text{V}$, 2.5V , 2.7V , 3.3V and 5.0V respectively.

[2] Typical values are measured at $V_{CC}=3.3\text{V}$ or 5V .

Testing Circuit

AC Testing Circuit

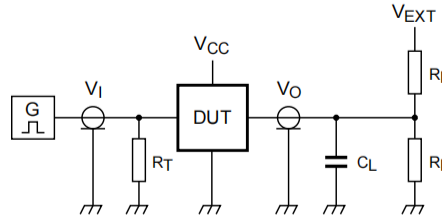


Figure 4. Test circuit for measuring switching times

Definitions for test circuit:

R_L =Load resistance.

C_L =Load capacitance including jig and probe capacitance.

R_T =Termination resistance; should be equal to the output impedance Z_o of the pulse generator.

V_{EXT} =External voltage for measuring switching times.

AC Testing Waveforms

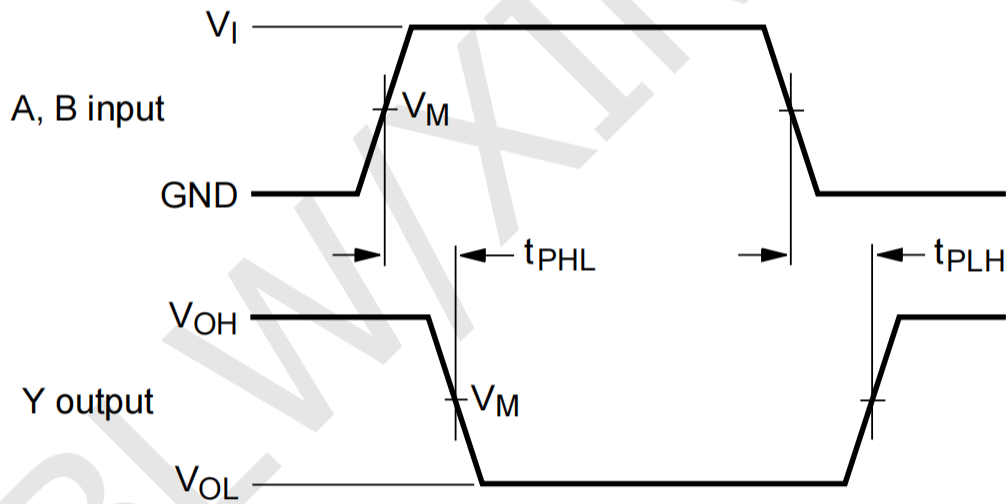


Figure 5. The input A, B to output Y propagation delays

Measurement Points

Supply voltage	Input	Output
V_{CC}	V_M	V_M
1.65V to 1.95V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
2.3V to 2.7V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
2.7V	1.5V	1.5V
3.0V to 3.6V	1.5V	1.5V
4.5V to 5.5V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$

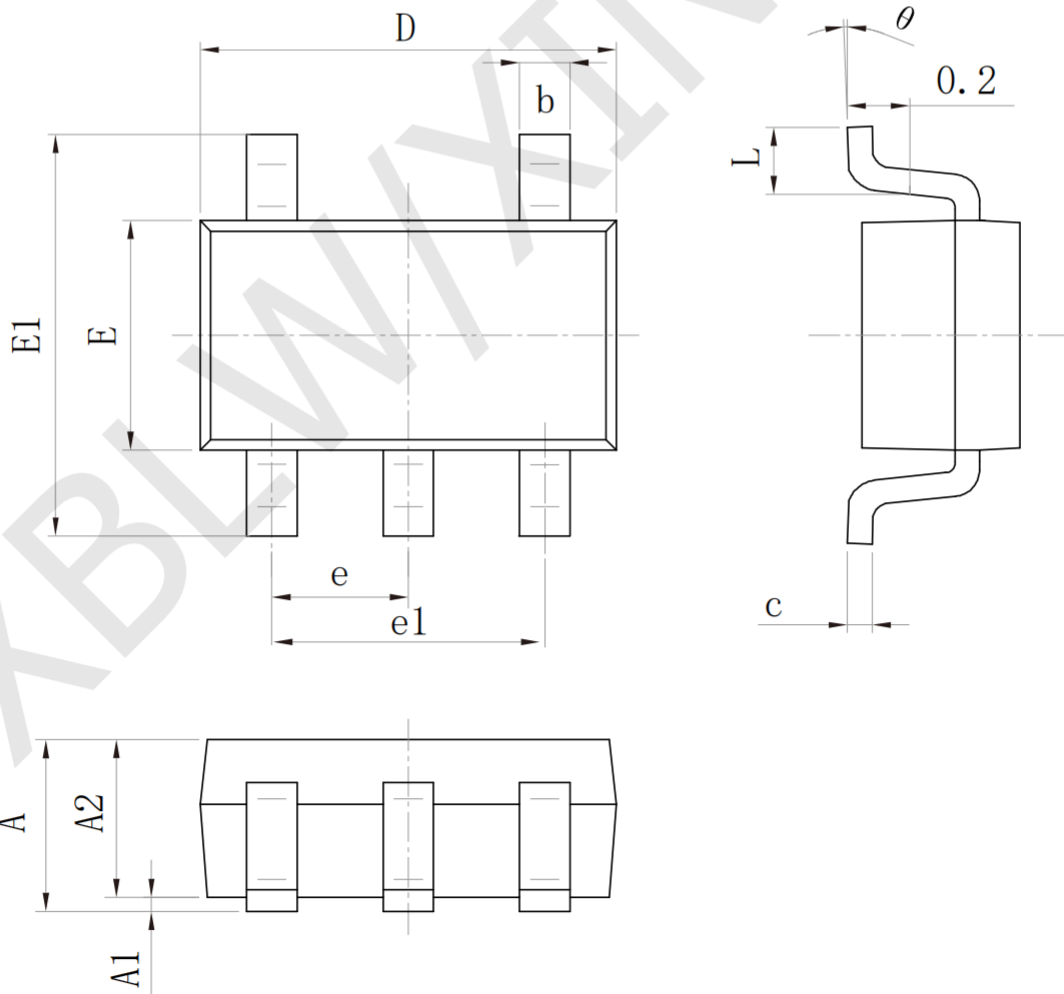
Test Data

Supply voltage	Input		Load		V_{EXT}
V_{CC}	V_I	$t_r = t_f$	C_L	R_L	t_{PLH}, t_{PHL}
1.65V to 1.95V	V_{CC}	$\leq 3ns$	30pF	1k Ω	open
2.3V to 2.7V	V_{CC}	$\leq 3ns$	30pF	500 Ω	open
2.7V	2.7V	$\leq 3ns$	50pF	500 Ω	open
3.0V to 3.6V	2.7V	$\leq 3ns$	50pF	500 Ω	open
4.5V to 5.5V	V_{CC}	$\leq 3ns$	50pF	500 Ω	open

Package Information

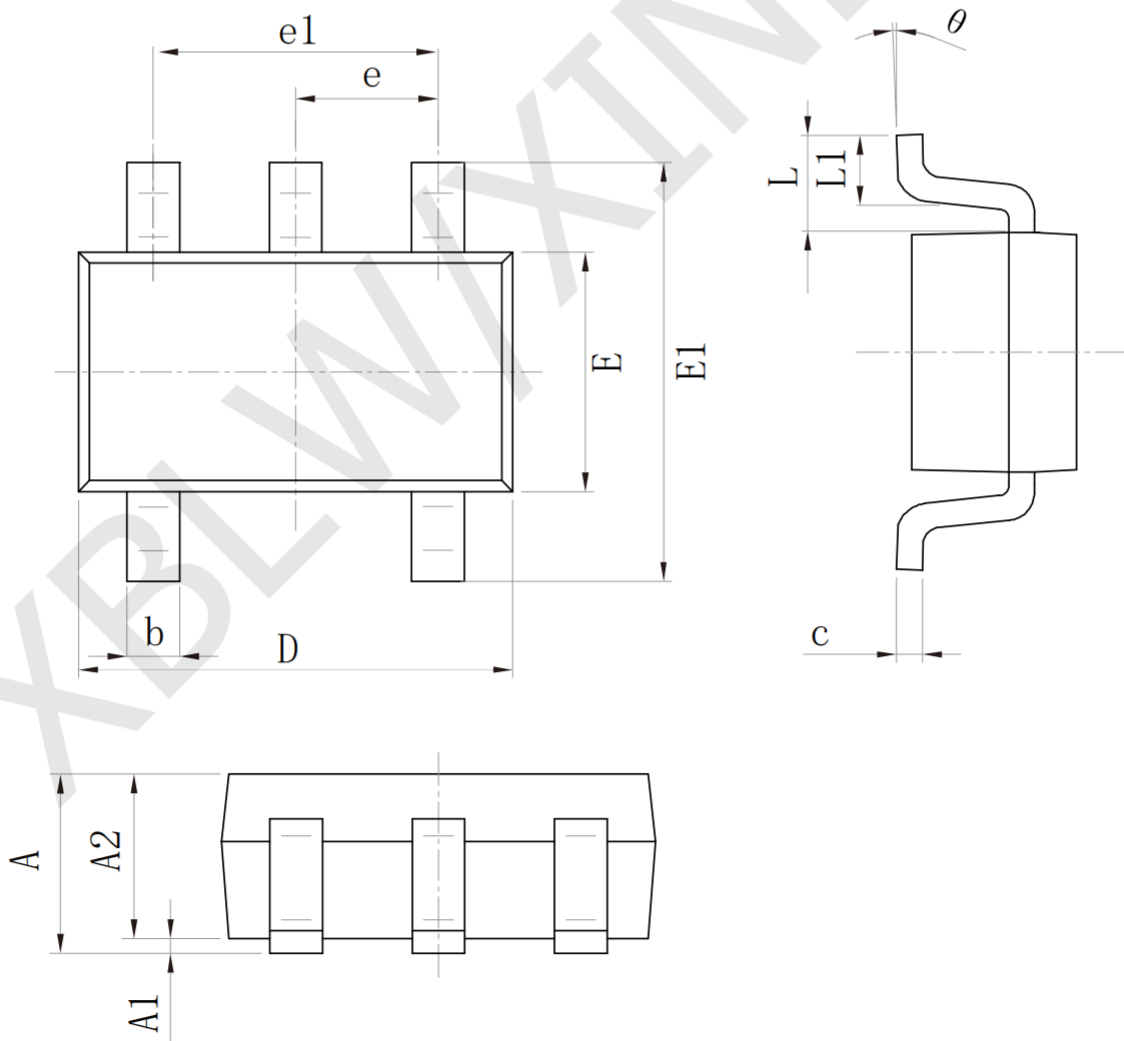
- SOT23-5

SIZE SYMBOL	Dimensions In Millimeters		SIZE SYMBOL	Dimensions In Inches	
	MIN (mm)	MAX (mm)		MIN (in)	MAX (in)
A	1.050	1.250	A	0.041	0.049
A1	0.000	0.100	A1	0.000	0.004
A2	1.050	1.150	A2	0.041	0.045
b	0.300	0.500	b	0.012	0.020
c	0.100	0.200	c	0.004	0.008
D	2.820	3.020	D	0.111	0.119
E	1.500	1.700	E	0.059	0.067
E1	2.650	2.950	E1	0.104	0.116
e	0.95 (BSC)		e	0.037 (BSC)	
e1	1.800	2.000	e1	0.071	0.079
L	0.300	0.600	L	0.012	0.024
θ	0°	8°	θ	0°	8°



• SOT-353

Size Symbol	Dimensions In Millimeters		Size Symbol	Dimensions In Inches	
	Min (mm)	Max (mm)		Min (in)	Max (in)
A	0.900	1.100	A	0.035	0.043
A1	0.000	0.100	A1	0.000	0.004
A2	0.900	1.000	A2	0.035	0.039
b	0.150	0.350	b	0.006	0.014
c	0.080	0.150	C	0.003	0.006
D	2.000	2.200	D	0.079	0.087
E	1.150	1.350	E	0.045	0.053
E1	2.150	2.450	E1	0.085	0.096
e	0.650 (TYP)		e	0.026 (TYP)	
e1	1.200	1.400	e1	0.047	0.055
L	0.525 (REF)		L	0.021 (REF)	
L1	0.260	0.460	L1	0.010	0.018
θ	0°	8°	θ	0°	8°



Statement:

- XBLW reserves the right to modify the product manual without prior notice! Before placing an order, customers need to confirm whether the obtained information is the latest version and verify the completeness of the relevant information.
- Any semi-guide product is subject to failure or malfunction under specified conditions. It is the buyer's responsibility to comply with safety standards when using XBLW products for system design and whole machine manufacturing. And take the appropriate safety measures to avoid the potential in the risk of loss of personal injury or loss of property situation!
- XBLW products have not been licensed for life support, military, and aerospace applications, and therefore XBLW is not responsible for any consequences arising from the use of this product in these areas.
- If any or all XBLW products (including technical data, services) described or contained in this document are subject to any applicable local export control laws and regulations, they may not be exported without an export license from the relevant authorities in accordance with such laws.
- The specifications of any and all XBLW products described or contained in this document specify the performance, characteristics, and functionality of said products in their standalone state, but do not guarantee the performance, characteristics, and functionality of said products installed in Customer's products or equipment. In order to verify symptoms and conditions that cannot be evaluated in a standalone device, the Customer should ultimately evaluate and test the device installed in the Customer's product device.
- XBLW documentation is only allowed to be copied without any alteration of the content and with the relevant authorization. XBLW assumes no responsibility or liability for altered documents.
- XBLW is committed to becoming the preferred semiconductor brand for customers, and XBLW will strive to provide customers with better performance and better quality products.

单击下面可查看定价，库存，交付和生命周期等信息

[>>XBLW\(芯伯乐\)](#)